

STY60NA20

N - CHANNEL 200V - 0.030Ω - 60 A - Max247 FAST POWER MOS TRANSISTOR

PRELIMINARY DATA

TYPE	V _{DSS}	R _{DS(on)}	I _D
STY60NA20	200 V	< 0.032 Ω	60 A

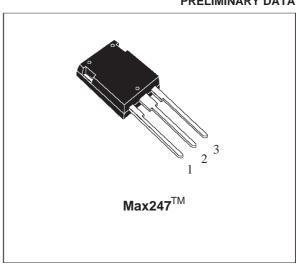
- TYPICAL $R_{DS(on)} = 0.030 \Omega$
- EFFICIENT AND RELIABLE MOUNTING THROUGH CLIP
- ± 30V GATE TO SOURCE VOLTAGE RATING
- REPETITIVE AVALANCHE TESTED
- LOW INTRINSIC CAPACITANCE
- 100% AVALANCHE TESTED
- GATE CHARGE MINIMIZED
- REDUCED THRESHOLD VOLTAGE SPREAD

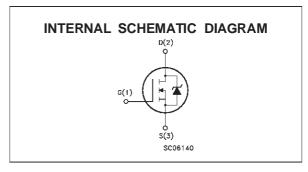
DESCRIPTION

The Max247TM package is a new high volume power package exibiting the same footprint as the industry standard TO-247, but designed to accommodate much larger silicon chips, normally supplied in bigger packages such as TO-264. The increased die capacity makes the device ideal to reduce component count in multiple paralleled designs and save board space with respect to larger packages.

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITCH MODE POWER SUPPLIES (SMPS)
- DC-AC CONVERTERS FOR WELDING EQUIPMENT AND UNINTERRUPTIBLE POWER SUPPLIES (UPS)





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source Voltage (V _{GS} = 0)	200	V
V _{DGR}	Drain- gate Voltage ($R_{GS} = 20 \text{ k}\Omega$)	200	V
V _{GS}	Gate-source Voltage	± 30	V
I _D	Drain Current (continuous) at T _c = 25 °C	60	А
I _D	Drain Current (continuous) at T _c = 100 °C	40	Α
I _{DM} (•)	Drain Current (pulsed)	240	Α
P _{tot}	Total Dissipation at T _c = 25 °C	300	W
	Derating Factor	2.4	W/°C
T _{stg}	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

(•) Pulse width limited by safe operating area

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THERMAL DATA

R _{thj-case} R _{thj-amb}	Thermal Resistance Junction-case Thermal Resistance Junction-ambient	Max Max	0.42 40	°C/W °C/W
R _{thc-sink}	Thermal Resistance Case-Heatsink	Тур	0.05	
	with Conductive Grease			

AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T _j max)	60	А
E _{AS}	Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	3000	mJ

ELECTRICAL CHARACTERISTICS ($T_{case} = 25$ $^{\circ}C$ unless otherwise specified) OFF

Symbol	Parameter	Test Con	Min.	Тур.	Max.	Unit	
V _{(BR)DSS}	Drain-source Breakdown Voltage	I _D = 250 μA	$V_{GS} = 0$	200			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	$V_{DS} = Max Rating$ $V_{DS} = Max Rating$	T _c = 100 °C			1 10	μΑ μΑ
Igss	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 30 V				± 100	nA

ON (*)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$ $I_D = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static Drain-source On Resistance	$V_{GS} = 10 \text{ V} I_{D} = 30 \text{A}$		0.03	0.032	Ω
I _{D(on)}	On State Drain Current	$V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $V_{GS} = 10 \text{ V}$	60			Α

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
gfs (*)	Forward Transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $I_D = 30 \text{ A}$	20			S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}$ f = 1 MHz $V_{GS} = 0$		6000 1400 500	8000 1900 700	pF pF pF

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ELECTRICAL CHARACTERISTICS (continued)

SWITCHING ON

Symbol	Parameter	Test Co	Min.	Тур.	Max.	Unit	
t _{d(on)}	Turn-on Time Rise Time	$V_{DD} = 100 \text{ V}$ $R_G = 4.7 \Omega$	$I_D = 30 A$ $V_{GS} = 10 V$		40 50	55 70	ns ns
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V _{DD} = 160 V I _D =	= 60 A V _G S = 10 V		285 40 150	370	nC nC nC

SWITCHING OFF

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
$t_{r(Voff)} $ t_{f} t_{c}	Off-voltage Rise Time Fall Time Cross-over Time	$V_{DD} = 160 \text{ V}$ $R_G = 4.7 \Omega$	$I_D = 60 A$ $V_{GS} = 10 V$		70 40 110	100 55 150	ns ns ns

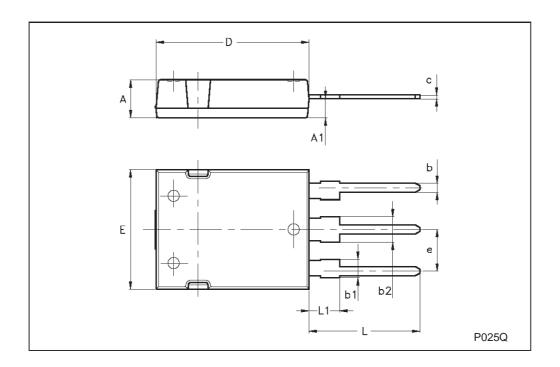
SOURCE DRAIN DIODE

Symbol	Parameter	Test Co	nditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} (•)	Source-drain Current Source-drain Current (pulsed)					60 240	A A
V _{SD} (*)	Forward On Voltage	I _{SD} = 60 A	$V_{GS} = 0$			1.5	V
t _{rr}	Reverse Recovery Time	I _{SD} = 60 A V _{DD} = 50 V	$di/dt = 100 \text{ A/}\mu\text{s}$ $T_i = 150 ^{\circ}\text{C}$		480		ns
Q_{rr}	Reverse Recovery		,		7.5		μC
I _{RRM}	Charge Reverse Recovery Current				30		А

^(*) Pulsed: Pulse duration = 300 μs, duty cycle 1.5 % (•) Pulse width limited by safe operating area

Max247 MECHANICAL DATA

DIM.		mm			inch	
Dilvi.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	4.70		5.30			
A1	2.20		2.60			
b	1.00		1.40			
b1	2.00		2.40			
b2	3.00		3.40			
С	0.40		0.80			
D	19.70		20.30			
е	5.35		5.55			
Е	15.30		15.90			
L	14.20		15.20			
L1	3.70		4.30			



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